Complex, Alka Society Main Road, Rajkot, Gujarat

Accreditation Standard ISO/IEC 17025: 2005

Certificate Number CC-2762 Page 1 of 4

Validity 04.07.2018 to 03.07.2020 Last Amended on -

SI.	Quantity Measured / Instrument	Range/Frequency	*Calibration Measurement Capability (±)	Remarks
I.	DIMENSION (BASIC MEASURING INSTRUMENT, GAUGE ETC.)			
1.	Calipers <sup>\$</sup> (Vernier/Dial/Digital) L.C.: 10 µm L.C.: 20 µm	0 to 600 mm 0 to 1000 mm	13.0 μm 22.0 μm	Using Caliper Checker & Gauge Block Set by Comparison Method as per IS 3651
2.	Depth Gauge <sup>\$</sup> (Vernier/Dial/Digital) L.C.: 10 μm <sup>Φ</sup>	0 to 300 mm	12.0 µm	Using Caliper Checker & Gauge Block Set by Comparison Method as per IS 4213
3.	Height Gauge <sup>\$</sup> (Vernier/Dial/Digital) L.C.: 1 μm <sup>Φ</sup> L.C.: 20 μm	0 to 600 mm 0 to 1000 mm	8.8 μm 21.0 μm	Using Caliper Checker & Gauge Block Set by Comparison Method as per IS 2921
4.	External Micrometer <sup>®</sup> L.C.: 1 μm <sup>Φ</sup>	0 to 100 mm 100 mm to 300 mm	1.6 μm 5.8 μm	Using Gauge Block Set & Long Gauge Block Set by Comparison Method as per IS 2967
5.	Inside Micrometer <sup>\$</sup> L.C.: 10 µm	Up to 1000 mm	12.3 µm	Using Gauge Block Set, Long Gauge Block Set & Electronic comparator with Probe by Comparison Method as per IS 2966
6.	Micrometer Setting Rod <sup>\$</sup>	Up to 275 mm	4.7 μm	Using Gauge Block Set, Long Gauge Block Set & Electronic comparator with Probe by Comparison Method

Rajeshwar Kumar Convenor Avijit Das Program Manager

Complex, Alka Society Main Road, Rajkot, Gujarat

Accreditation Standard ISO/IEC 17025: 2005

Certificate Number CC-2762 Page 2 of 4

Validity 04.07.2018 to 03.07.2020 Last Amended on -

SI.	Quantity Measured / Instrument	Range/Frequency	*Calibration Measurement Capability (±)	Remarks
7.	Dial Gauge <sup>®</sup> (Plunger Type) L.C.: 1 µm <sup>©</sup>	0 to 10 mm	1.6 μm	Using Electronic Dial Calibration Tester by Comparison Method
8.	Dial Gauge <sup>®</sup> (Lever Type) L.C.: 1 µm <sup>Φ</sup>	0 to 2 mm	1.63 µm	Using Electronic Dial Calibration Tester by Comparison Method
9.	Bore Gauge With Dial For Transmission Accuracy <sup>\$</sup> L.C.: 0.1µm <sup>Φ</sup>	Up to 1.0 mm	3.1 µm	Using Electronic Dial Calibration Tester by Comparison Method
10.	Plain Plug Gauge <sup>\$</sup>	1 mm to 400 mm	4.7 μm	Using Gauge Block Set, Long Gauge Block Set & Electronic Comparator With Probe by Comparison Method
11.	Snap Gauge <sup>\$</sup>	1 mm to 250 mm	3.6 μm	Using Gauge Block Set by Comparison Method
12.	Dial Calibration Tester <sup>\$</sup> L.C.: 0.1 µm	Up to 25 mm	1.5 µm	Using Electronic Probe With DRO by Comparison Method
13.	Electronic Probe with DRO <sup>\$</sup> L.C.: 0.1 µm	Up to 25 mm	2.3 μm	Using Gauge Block & Electronic Probe by Comparison Method
14.	Bevel Protractor <sup>®</sup> L.C.: 5 min	0° - 90° - 0°	4.1 min of Arc	Using Gauge Block Set; Sine Bar & Surface Plate by Comparison Method
15.	Depth Micrometer <sup>s</sup> L.C.: 10 μm	0 to 300 mm	12.1 µm	Using Gauge Block Set by Comparison Method

Rajeshwar Kumar Convenor Avijit Das Program Manager

Complex, Alka Society Main Road, Rajkot, Gujarat

Accreditation Standard ISO/IEC 17025: 2005

Certificate Number CC-2762 Page 3 of 4

Validity 04.07.2018 to 03.07.2020 Last Amended on -

SI.	Quantity Measured / Instrument	Range/Frequency	*Calibration Measurement Capability (±)	Remarks
16.	Thread Measuring Wire / Measuring Pin <sup>\$</sup>	0.1 mm to 10 mm	1.5 μm	Using Electronic Probe by Comparison Method
17.	Pistol Caliper <sup>\$</sup> L.C.: 100 μm	Up to 50 mm	40.0 μm	Using Gauge Block Set by Comparison Method
18.	Dial Snap Gauge <sup>\$</sup> L.C.: 1 µm	1 mm to 100 mm	1.5 µm	Using Gauge Block Set by Comparison Method
19.	Dial Thickness Gauge <sup>\$</sup> L.C.: 10 μm	Up to 50 mm	7.9 µm	Using Gauge Block Set by Comparison Method
20.	Dial Caliper Gauge <sup>\$</sup> (Internal) L.C.: 10 μm	Up to 100 mm	12.8 µm	Using Gauge Block Set & Gauge Block Accessories Set by Comparison Method
21.	Dial Caliper Gauge <sup>\$</sup> (External) L.C.: 10 μm	Up to 100 mm	7.9 µm	Using Gauge Block Set by Comparison Method
22.	Feeler Gauge <sup>\$</sup>	Up to 1 mm	1.7 µm	Using Electronic Probe by Comparison Method
23.	Plain Ring Gauge <sup>\$</sup>	2 mm to 100 mm	3.7 µm	Using LLM & Master Plain Ring Gauge by Comparison Method
24.	Thread Plug Gauge <sup>\$</sup> (Effective Dia. Only)	2 mm to 200 mm	3.8 µm	Using LLM & Thread Measuring Wire by Comparison Method

Rajeshwar Kumar Convenor Avijit Das Program Manager

Complex, Alka Society Main Road, Rajkot, Gujarat

Accreditation Standard ISO/IEC 17025: 2005

Certificate Number CC-2762 Page 4 of 4

Validity 04.07.2018 to 03.07.2020 Last Amended on -

SI.	Quantity Measured / Instrument		*Calibration Measurement Capability (±)	Remarks
25.	Thread Ring Gauge <sup>\$</sup> (Effective Dia. Only)	2 mm to 100 mm	5.3 μm	Using LLM & Master Plain Ring Gauge by Comparison Method

 $<sup>^{\</sup>star}$  Measurement Capability is expressed as an uncertainty (±) at a confidence probability of 95%  $^{\$}$  Only in Permanent Laboratory

Rajeshwar Kumar Convenor

<sup>&</sup>lt;sup>o</sup> Laboratory can also calibrate instruments/devices of coarser resolution / least count within the accredited range using same reference standard/ master equipment under the scope of accreditation.